

Search Notes**Application/Control No.**

10/531,343

Examiner

/Yonel Beaulieu/

**Applicant(s)/Patent under
Reexamination**

MICH I ET AL.

Art Unit

3661

SEARCHED

Class	Subclass	Date	Examiner
701	200	10/15/2008	YB
	210		
	117		
	25-26		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
Int. Search		10/15/2008	YB

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
WEST+Int.+Bwd/Fwd	10/15/2008	YB